

## C0603C202J5HACTU

Aliases (C0603C202J5HAC7867) SMD Comm X8R HT150C, Ceramic, 2,000 pF, 5%, 50 VDC, X8R, SMD, MLCC, High Temperature, Ultra-Stable, 0603, 0.5 mm



Click here for the 3D model.

0603

1.6mm +/-0.15mm

0.8mm +/-0.15mm

0.8mm +/-0.07mm

0.35mm +/-0.15mm

T&R, 180mm, Paper Tape

0.5mm MIN

4000

General Information		
Series	SMD Comm X8R HT150C	
Style	SMD Chip	
Description	SMD, MLCC, High Temperature, Ultra-Stable	
Features	High Temperature, Ultra-Stable	
RoHS	Yes	
Termination	Tin	
Marking	No	
AEC-Q200	No	
Typical Component Weight	4.8 mg	
Shelf Life	78 Weeks	
MSL	1	

Specifications	
Capacitance	2,000 pF
Measurement Condition	1 kHz 1.0Vrms
Tolerance	5%
Voltage DC	50 VDC
Dielectric Withstanding Voltage	125 VDC
Temperature Range	-55/+150°C
Temp. Coefficient	X8R
Capacitance Change with Reference to +25°C and 0 VDC Applied (TCC)	15%, 1kHz 1.0Vrms
Dissipation Factor	2.5%1kHz1.0Vrms
Aging Rate	0% Loss/Decade Hour: Referee Time is 1000 Hours
Insulation Resistance	100 GOhms

Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute – and we specifically disclaim – any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.

Dimensions

**Packaging Specifications** 

Packaging Quantity

Chip Size

L

W T

s

в

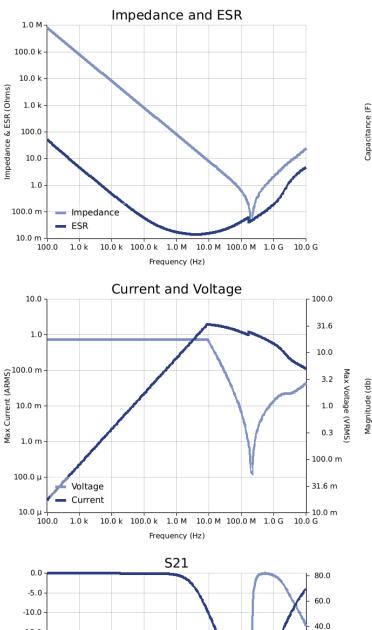
Packaging



CO603C202J5HACTU Aliases (C0603C202J5HAC7867) SMD Comm X8R HT150C, Ceramic, 2,000 pF, 5%, 50 VDC, X8R, SMD, MLCC, High Temperature, Ultra-Stable, 0603, 0.5 mm

## Simulations

For the complete simulation environment please visit K-SIM.



20.0

0.0

-20.0

-40.0

-60.0

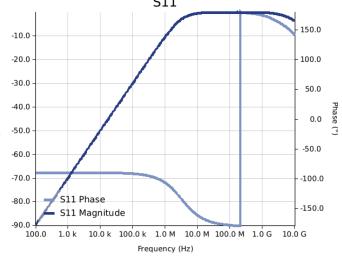
-80.0

10.0 G

Phase

°

Capacitance and Inductance 100.0 n 1.0 n 63.1 n 0.6 n 39.8 n 0.4 n 25.1 n 0.3 n 15.8 n 0.2 n a Capacitance (F) 100.0 p 10.0 n tan 6.3 n 63.1 p 🗄 4.0 n 39.8 p 2.5 n 25.1 p Inductance 1.6 n 15.8 p Capacitance 1.0 n 10.0 p 10.0 k 100.0 k 1.0 M 10.0 M 100.0 M 1.0 G 10.0 G 1.0 k 100.0 Frequency (Hz) S11



100.0

S21 Phase

S21 Magnitude

1.0 k 10.0 k 100.0 k 1.0 M 10.0 M 100.0 M 1.0 G

Frequency (Hz)

-15.0 -20.0

-25.0

-30.0

-35.0

-40.0 -45.0

-50.0

Magnitude (db)



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## These are simulations.

This is not a specification!

The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

The responses shown do not represent a specified or implied maximum capability of the device for all applications.

- The ESR used for ripple "Ripple Current/Voltage vs. Frequency" plots is the ESR at ambient temperature.

- The ESR used for hipple klipple current younge vs. requericy plots is the ESR at an bient temperature.
  The ESR in the "Temperature Rise vs. Ripple Current" plots is adjusted to each incremental temperature rise before the power and ripple current is calculated.
  The effects shown herein are based on measured data from a multiple part sample of the parts in question.
  Ripple capability of this device will be factored by thermal resistance (Rth) created by circuit traces (addi affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.
  The peak voltages generated in the "Temperature Rise vs. Combined Ripple Currents" plot are calculated for each frequency and are not combined with voltages and the part of the parts of the part of the
- generated at any other harmonics. Please consult with the catalog or field applications engineer for maximum capability of the device in specific applications.

All product information and data (collectively, the "Information") are subject to change without notice.

KEMET K-SIM is designed to simulate behavior of components with respect to frequency, ambient temperature, and DC bias levels. The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation effects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

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If you have any questions please contact K-SIM.